

MC68030 ELECTRICAL SPECIFICATIONS



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ELECTRICAL SPECIFICATIONS

MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
|---|------------------|----------------|------|
| Supply Voltage* | Vcc | -0.3 to +7.0 | V |
| Input Voltage | V _{in} | - 0:5 to + 7.0 | ٠V |
| Operating Temperature Range Minimum Ambient Temperature 40-MHz Maximum Ambient Temperature 50-MHz Maximum Case Temperature | TA TA | 0 70 80 | °C |
| Storage Temperature Range | T _{stg} | -55 to 150 | °C |

^{*}A continuous clock must be supplied to the MC68030 when it is powered up.

This device contains protective circuitry against damage due to high static voltages or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (e.g., either GND or V_{CC}).

THERMAL CHARACTERISTICS — PGA PACKAGE

| Characteristic | Symbol | Value | Rating |
|---|--------|------------|--------|
| Thermal Resistance — Ceramic Junction to Ambient Junction to Case | θJC . | 30* 15* | °C/W |

^{*}Estimated



POWER CONSIDERATIONS

The average chip-junction temperature, T_J, in °C can be obtained from:

$$T_{J} = T_{A} + (P_{D} \cdot \theta_{JA}) \tag{1}$$

where:

T_A = Ambient Temperature, °C θ_J_A = Package Thermal Resistance, Junction-to-Ambient, °C/W

PD = PINT + PI/O

 P_{INT} = $I_{CC} \times V_{CC}$, Watts — Chip Internal Power $P_{I/O}$ = Power Dissipation on Input and Output Pins

User Determined

For most applications P_{I/O}<P_{INT} and can be neglected.

The following is an approximate relationship between P_D and T_J (if $P_{I/O}$ is neglected):

$$P_D = K \div (T_1 + 273^{\circ}C)$$
 (2)

Solving equations (1) and (2) for K gives:

$$K = P_D \cdot (T_A + 273^{\circ}C) + \theta_{JA} \cdot P_D^2$$
 (3)

where K is a constant pertaining to the particular part. K can be determined from equation (3) by measuring PD (at equilibrium) for a known TA. Using this value of K, the values of PD and TJ can be obtained by solving equations (1) and (2) iteratively for any value of TA.

The total thermal resistance of a package (θJA) can be separated into two components, θJC and θCA , representing the barrier to heat flow from the semiconductor junction to the package (case) surface (θJC) and from the case to the outside ambient (θCA) . These terms are related by the equation:

$$\theta_{JA} = \theta_{JC} + \theta_{CA} \tag{4}$$

 θ JC is device related and cannot be influenced by the user. However, θ CA is user dependent and can be minimized by such thermal management techniques as heat sinks, ambient air cooling, and thermal convection. Thus, good thermal management on the part of the user can significantly reduce θ CA so that θ JA approximately equals θ JC. Substitution of θ JC for θ JA in equation (1) will result in a lower semiconductor junction temperature.

Values for thermal resistance presented in this document, unless estimated, were derived using the procedure described in Motorola Reliability Report 7843, "Thermal Resistance Measurement Method for MC68XX Microcomponent Devices," and are provided for design purposes only. Thermal measurements are complex and dependent on procedure and setup. User derived values for thermal resistance may differ.

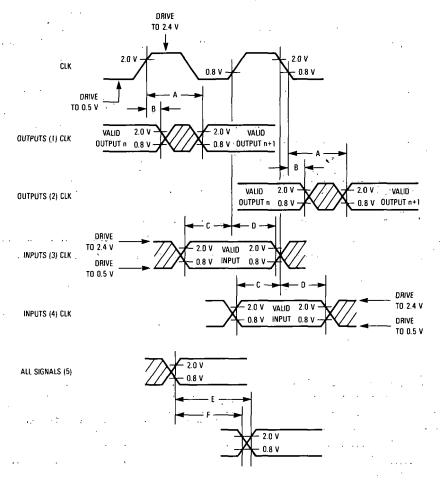
AC ELECTRICAL SPECIFICATIONS DEFINITIONS

The AC specifications presented consist of output delays, input setup and hold times, and signal skew times. All signals are specified relative to an appropriate edge of the MC68030 clock input and, possibly, relative to one or more other signals.

The measurement of the AC specifications is defined by the waveforms in Figure 1. To test the parameters guaranteed by Motorola, inputs must be driven to the voltage levels specified in Figure 1. Outputs of the MC68030 are specified with minimum and/or maximum limits, as appropriate, and are measured as shown. Inputs to the MC68030 are specified with minimum and, as appropriate, maximum setup and hold times, and are measured as shown. Finally, the measurements for signal-to-signal specifications are also shown.

Note that the testing levels used to verify conformance of the MC68030 to the AC specifications does not affect the guaranteed DC operation of the device as specified in the DC electrical characteristics.





NOTES:

- 1 This output timing is applicable to all parameters specified relative to the rising edge of the clock
- 2 This output timing is applicable to all parameters specified relative to the falling edge of the clock
- 3 This input timing is applicable to all parameters specified relative to the rising edge of the clock
- 4 This input timing is applicable to all parameters specified relative to the falling edge of the clock
- 5 This timing is applicable to all parameters specified relative to the assertion/negation of another signal

LEGEND:

- A Maximum output delay specification
- B Minimum output hold time
- C Minimum input setup time specification
- D Minimum input hold time specification
- E Signal valid to signal valid specification (maximum or minimum)
- F Signal valid to signal invalid specification (maximum or minimum)

Figure 1. Drive Levels and Test Points for AC Specifications



DC ELECTRICAL SPECIFICATIONS

 $(V_{CC} = 5.0 \text{ Vdc} \pm 5\%; \text{ GND} = 0 \text{ Vdc}; 40 \text{ MHz-T}_A = 0^{\circ} \text{ to } 70^{\circ}\text{C}, 50 \text{ MHz-T}_A = 0^{\circ}\text{C to } T_{C} = 80^{\circ}\text{C})$

| | Characteristic | Symbol | Min | Max | Únit |
|---|--|-------------------|--------------|--------------------------|----------|
| Input High Voltage | · · · · · · · · · · · · · · · · · · · | . V _{tH} | 2.0 | Vcc | V· |
| Input Low Voltage | | V _{IL} | GND 0.5 | 0.8 | ٢٧ |
| Input Leakage Current GND $\leq V_{in} \leq V_{CC}$ | BERR, BR, BGACK, CLK, IPLO-IPL2, AVEC, CDIS, DSACKO, DSACK1 | | - 2.5 | 2.5 | μА |
| Hi-Z (Off-State) Leakage Current @ 2.4 V/0.5 V | HALT, RESET A0-A31, AS, DBEN, DS, D0-D31, FC0-FC2, R/W, RMC, SIZ0-SIZ1 | I _{TSI} | - 20 - 20 | 20 | μА |
| Output High Voltage A0-A3 I _{OH} = 400 μA | 1, AS, BG, D0-D31, DBEN, DS, ECS, R/W, IPEND, OCS, RMC, SIZ0-SIZ1, FC0-FC2, CBREQ, CIOUT, STATUS, REFILL | V _{ОН} | 2.4 | _ | ٧. |
| Output Low Voltage IOL = 3.2 mA IOL = 5.3 mA IOL = 2.0 mA IOL = 10.7 mA | A0-A31, FC0-FC2, SIZ0-SIZ1, BG, D0-D31 CBREO, AS, DS, R/W, RMC, DBEN, IPEND STATUS, REFILL, CIOUT, ECS, OCS RESET | V _{OL} | | 0.5 0.5 0.5 0.5 | V |
| Power Dissipation (T _A = 0°C) | | P _D . | _ | 2.6 | w |
| Capacitance (see Note) $V_{in} = 0 \text{ V}, T_A = 25^{\circ}\text{C}, f = 1 \text{ MHz}$ | | C _{in} | | 20 | рF |
| Load Capacitance | ECS, OCS CIOUT, STATUS, REFILL All Other | СL | _ | 50 70 130 | pF |

NOTE: Capacitance is periodically sampled rather than 100% tested.

AC ELECTRICAL SPECIFICATIONS — CLOCK INPUT (see Figure 2)

| Num. | Characteristic | 20 | 20 MHz | | 25 MHz | | 33.33 MHz | | 40 MHz | | 50 MHz* | |
|------|---|------|--------|------|--------|-----|-----------|------|--------|-----|---------|------|
| Num. | Characteristic | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | Unit |
| | Frequency of Operation | 12.5 | · 20 | 12.5 | 25 | 20 | 33.33 | 25 | 40 | 25 | 50 | MHz |
| 1 | Cycle Time Clock | 50 | -80 | 40 | 80 | 30 | 50 | 25 | 40 | 20 | 40 | ns |
| 2, 3 | Clock Pulse Width Measured from 1.5 V to 1.5 V | 23 | 57 | 19 | - 61 | 14 | 36 | 11.5 | 29 | 9.5 | 30.5 | ns |
| 4, 5 | Clock Rise and Fall Times | - T | 5 | | 4 | _ | 3. | _ | 2 | _ | 2 | ns |

^{*}T_{case} = 80°C Maximum



AC ELECTRICAL SPECIFICATIONS — READ AND WRITE CYCLES ($V_{CC} = 5.0 \text{ Vdc} \pm 5\%$; GND = 0 Vdc; 40 MHz-TA = 0° to 70°C, 50 MHz-TA = 0°C to TC = 80°C) (see Figures .3–8)

| | 2 | 20 1 | VIHz | 25 1 | ИНZ | 33.33 | MHz | 40 (| VIHz | 50 MHz* | | |
|-------------------|---|------|------------|------|-----|-------|-----|------------------|----------|---------|--------------|------|
| Num. | Characteristic | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | Unit |
| 6 | Clock High to Function Code, Size, RMC, IPEND, CIOUT, Address Valid | . 0 | 25 | 0 | 20 | 0 | 14 | 0 | 14 | 0 | 14 | ns |
| 6A | Clock High to ECS, OCS Asserted | 0 | 15 | 0 | 15 | 0 | 12 | 0 | 10 | 0 | 10 | ns |
| 6B . | Function Code, Size, RMC, IPEND, CIOUT, Address Valid to Negating Edge of ECS | 4 | - | 3 | | 3 | 1 | 3 | ï | 3 | - | ns |
| . 7 | Clock High to Function Code, Size, RMC, CIOUT, Address, Data High Impedance | 0 | 50 | 0 | 40 | 0 | 30 | 0 | 25 | 0 | 20 | ns |
| .8 | Clock High to Function Code, Size, RMC, IPEND, CIOUT, Address Invalid | 0 | _ | 0 | _ | 0 | | 0 | | 0 | _ | ns |
| 9 | Clock Low to AS, DS Asserted, CBREQ Valid | 3 | 20 | 3 | 18 | 2 | 10 | 2 | 10 . | 2 | 10 | ns |
| 9A ¹ | AS to DS Assertion Skew (Read) | - 10 | 10 | - 10 | 10 | -8 | 8 | - 6 | 6 | -6 | 6 | ns |
| 9B ¹⁴ | AS Asserted to DS Asserted (Write) | 32 | _ | 27 | 1 | 22 | _ | 16 | _ | 14 | | ns |
| 10 | ECS Width Asserted | 15 | | 10 | | -8 | | . 5 | | 4 | _ | ns |
| · 10A | OCS Width Asserted | 15 | | 10 | ١ | 8 | 1 | 5 | | 4 | | ns |
| 108 ⁷ | ECS, OCS Width Negated | 10 | | 5 | | 5 | | . 5 [.] | - | 4 | | ns |
| . 11 | Function Code, Size, RMC, CIOUT, Address Valid to Asserting Edge of AS Asserted (and DS Asserted, Read) | 10 | _ | 7 | | .5. | _ | 5 | _ | 3 | | ns |
| 12 | Clock Low to AS, DS, CBREQ Negated | 0 | 20 | 0 | 18 | . 0 | 10 | 0 | 10 | 0 | 10 | ns |
| 12A | Clock Low to ECS/OCS Negated | 0 | 20 | 0 . | 18 | 0 | 15 | 0 | 12 | 0 | 11 | ns · |
| 13 | AS, DS Negated to Function Code, Size, RMC, CIOUT, Address Invalid | 10 | | 7 | | 5 | : | 3 | | 3 | _ | ns |
| .14 | AS (and DS Read) Width Asserted (Asynchronous Cycle) | 85 | _ | 70 | 1 | 45*. | | 30 | _ | 25 | _ | ns |
| 14A ¹¹ | DS Width Asserted (Write) | 38 | - <u>-</u> | 30 | | 23 | _ | 18 | | 13 | | ns |
| 14B | AS (and DS, Read) Width Asserted (Synchronous Cycle) | 35 | _ | 30 | _ | 23 | · | 18 | _ | 13 | _ | ns |
| , 15 | AS, DS Width Negated | 38 | | 30 | | 23 | | 18 | | . 13 | | ·ns |
| 15A8 | DS Negated to AS Asserted | 30. | <u> </u> | 25 | | 18 | | 16 . | <u> </u> | 14 | <u>L – </u> | ns |
| 16 | Clock High to AS, DS, R/W, DBEN, CBREQ High Impedance | _ | 50 | _ | 40 | _ | 30 | | 25 | _ | 20 | ns |



AC ELECTRICAL SPECIFICATIONS (Continued)

| | | 20 1 | VIHz | 25 1 | ИНz | 33.33 | MHz | 40 MHz | | 50 MHz* | | |
|---------------------|--|----------|---------------|--------------|-----|-------|--------|----------|-------|---------|-----|------|
| Num. | Characteristic | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | Unit |
| 17 . | AS, DS Negated to R/W Invalid | 10: | . | 7 | -: | 5 | _ | 3 | _ | 3 | _ | ns |
| 18 | Clock High to R/W High | 0 | 25 | 0 | 20 | 0 | 15 | 0 | 14 | 0 | 14 | ns |
| 20 | Clock High to R/W Low | 0 | 25 | 0 | 20 | 0 | 15 | 0. | 14 | 0 | 14 | ns |
| 21 | R/W High to AS Asserted | 10 | _ | `7 . | - | 5 | - | 5 | | 3 | _ | ns |
| 22 | R/W Low to DS Asserted (Write) | 60 | _ | 47 | _ | ' 35 | _ | 24 | . — | 23 | _ | . us |
| 23 | Clock High to Data-Out Valid | _ | 25 | , — <u>.</u> | 20 | | 14 | _ | 14 | _ | 14 | nś |
| 24 | Data-Out Valid to Negating Edge of AS | 8 | | 5 | 1 | 3 | _ | 3 . | _ | 3. | 1 | ns |
| 2511 | AS, DS Negated to Data-Out Invalid | 10 | _ | 7 | _ | 5 | | 3 | - | . 3 | - | ns |
| 25A ^{9,11} | DS Negated to DBEN Negated (Write) | 10 | _ | 7 | _ | 5 | _ | 3 | _ | 3 | | ns |
| 26,11 | Data-Out Valid to Asserting Edge of DS Asserted (Write) | 10 | _ | 7 | | 5 | | 3 | _ | 3. | + | ns |
| 27 | Data-In Valid to Clock Low (Setup) | 4 | _ | 2 | _ | 1 | _ | 1 | _ | 1 | _ | ns |
| 27A | Late BERR/HALT Asserted to Clock Low (Setup) | 10 | _ | 5 | _ | 3 | _ | 3 | | 3. | _ | ns |
| 2812 | AS, DS Negated to DSACKx, BERR, HALT, AVEC Negated (Asynchronous Hold) | 0 | 50 | 0 | 40 | 0 | . 30 | 0 | 20 | 0 | 15 | ns |
| 28A ¹ 2 | Clock Low to DSACKx, BERR, HALT, AVEC Negated (Synchronous Hold) | 12 | 85 | 8 | 70 | 6 | 50 | 6 | 40 | 6 | 35 | ns |
| 29 ¹² | AS, DS Negated to Data-In Invalid (Asynchronous Hold) | 0 | _ | 0 | | 0 | | 0 | l – . | 0 | _ | ns |
| 29A ¹² | AS, DS Negated to Data-In High Impedance | - | 50 | _ | 40 | - | 30 | _ | 25 | - | 20 | ns |
| 3012 | Clock Low to Data-In Invalid (Synchronous Hold) | 12 | _ | . 8 | _ | 6 | _ | 6 | _ | 6 | | ns |
| 30A ¹² | Clock Low to Data-In High Impedance (Read followed by Write) | _ | 75 | | 60 | | 45 | _ | 30 | | 25 | ns |
| 31 ² . | DSACKx Asserted to Data-In Valid (Asynchronous Data Setup) | _ | 43 | _ | 28 | _ | 20 | . — | 14 | _ | 13 | ns |
| 31A ³ | DSACKx Asserted to DSACKx Valid (Skew) | _ | 10 | _ | 7 | | 5 | <i>-</i> | | _ | 3 | ns |
| 32 | RESET Input Transition Time | <u> </u> | 1.5 | | 1.5 | _ | .1.5 . | | .1.5 | · | 1.5 | Clks |
| 33 | Clock Low to BG Asserted | 0 | 25 | 0 | 20 | 0 | 15 | 0, , | 14 | 0 | 14 | ns |
| 34 | Clock Low to BG Negated | 0 | 25 | 0 | 20 | 0 | 15 | 0 | 14 | .0 | 14 | ns |
| 35 | BR Asserted to BG Asserted (RMC Not Asserted) | 1.5 | 3.5 | 1.5 | 3.5 | 1.5 | 3.5 | 1.5 | 3.5 | 1.5 | 3.5 | Clks |



AC ELECTRICAL SPECIFICATIONS (Continued)

| Num. | Chanachaninain | 20 1 | VIHż | 25 | VIHz | 33:33 | MHz | 40 (| VIHz | 50 N | /iHz* | Unit |
|------------------|--|-----------|----------|----------|--------|----------|--------------|----------|----------------|----------|-------------|------|
| Num. | Characteristic | Min | Max | ' Min | Max | ·Min | Max | Min | Max | Min | Max | Unit |
| 37 | BGACK Asserted to BG Negated | 1.5 | 3.5 | 1.5 | 3.5 | 1.5 | 3.5 | 1.5 | 3.5 | 1.5 | 3.5 | Clks |
| 37A ⁶ | BGACK Asserted to BR Negated | .0 | 1.5 | 0, | 1.5 | 0 | 1.5 | 0 | 1.5 | 0 | 1.5 | Clks |
| 39 | BG Width Negated | 75 | _ | 60 | _ | 45 | _ | 30 | | 30 | | ns |
| 39A | BG Width Asserted | 75 | | 60 | | 45 | ·- | 30 | | 30 | | ns |
| 40 | Clock High to DBEN Asserted (Read) | 0 | 25 | 0 | 20 | 0 | 18 | 0 | 16 | 0 | 14 | ns |
| · 41 | Clock Low to DBEN Negated (Read) | 0 | 25 | 0 | 20 | 0 | 18 | 0 | 16 | 0 | 14 | ns |
| 42 | Clock Low to DBEN Asserted (Write) | 0 | 25 | 0 | 20 | 0 | 18 | 0 | 16 | 0 | 14 | ns |
| 43 ' | Clock High to DBEN Negated (Write) | 0 | 25 | 0 | 20 | 0 | 18 | 0 | 16 | 0 | 14 | ns |
| 44 | R/W Low to DBEN Asserted (Write) | 10 | | 7 | _ | 5 | 1 | 5 | _ | 5 | _ | ns |
| 45 ⁵ | DBEN Width Asserted Asynchronous Read Asynchronous Write | 50 100 | _ | 40 80 | _ | 30 60 | _ | 22 45 | 1.1 | 20 40 | _ | ns |
| 45A ⁹ | DBEN Width Asserted Synchronous Read Synchronous Write | 10 50 | _ | 5 40 | - - | 5 30 | _ | 5 22 | | 5 20 | | ns |
| 46 | R/W Width Asserted (Asynchronous Write or Read) | 125 | - | 100 | | 75 | - | 50 | - | 40 | . 1 | ns |
| 46A | R/W Width Asserted (Synchronous Write or Read) | 75 | <u> </u> | 60 | | 45 | _ | 30 | - | 25 | - | ns |
| 47A | Asynchronous Input Setup Time to Clock Low | 4 | _ | 2 | _ | 2 | - | 2 | _ | 2 | _ | ns |
| 478 | Asynchronous Input Hold Time from Clock Low | 12 | | 8 | - | 6 | _ | 6 | - . | 6 | _ | ns |
| 484 | DSACKx Asserted to BERR, HALT Asserted | . – | 20 | _ | 25 | _ | 18 | | 14 | - | 13 | ns |
| 53 | Data-Out Hold from Clock High | 3 | _ | 3, | _ | 2 | _ | 2 | _ | 2 | _ | ns |
| 55 | R/W Asserted to Data Bus Impedance Change | 25 | _ | 20 | _ | 15 | _ | 11 | | 11 | _ | ns |
| 56 | RESET Pulse Width (Reset Instruction) | 512 | | 512 | _ | 512 | _ | 512 | 1 | 512 | - 1 | Clks |
| 57 | BERR Negated to HALT Negated (Rerun) | 0 | | 0 | _ | 0 | - | 0 | _ | 0 | _ | ns |
| 58 ¹⁰ | BGACK Negated to Bus Driven | 1 | _ | .1 | | 1 | _ | -1 | _ | 1 | _ | Clks |
| 5910 | BG Negated to Bus Driven | 1 | _ | 1 | | 1 | _ | 1 | _ | 1 | _ | Clks |



AC ELECTRICAL SPECIFICATIONS (Concluded)

| Num. | Characteristic | 20 1 | 20 MHz | | 25 MHz | | 33.33 MHz | | 40 MHz | | 50 MHz* | |
|------------------|---|------|--------|-----|--------|-----|-----------|-----|--------|-----|---------|------|
| Mulli. | Characteristic | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | Unit |
| 60 ¹³ | Synchronous Input Valid to Clock High (Setup Time) | 4 | _ | 2 | - | 2 | | 2 | - | 2 | _ | ns |
| 61 ¹³ | Clock High to Synchronous Input Invalid (Hold Time) | 12 | _ | 8 | | 6 | _ | 6 | _ | 6 | _ | ns |
| 62 | Clock Low to STATUS, REFILL Asserted | 0 | 25 | 0 | 20 | 0 | 15 | 0 | 15 | 0 | 15 | ns |
| 63 | Clock Low to STATUS, REFILL Negated | 0 | 25 | 0 | 20 | 0 | 15 | 0 | 15 | 0 | 15 | ns |

NOTES

*Tcase = 80°C Maximum

- 1. This number can be reduced to 5 ns if strobes have equal loads.
- 2. If the asynchronous setup time (#47A) requirements are satisfied, the DSACKx low to data setup time (#31) and DSACKx low to BERR low setup time (#48) can be ignored. The data must only satisfy the data-in clock low setup time (#27) for the following clock cycle, and BERR must only satisfy the late BERR low to clock low setup time (#27A) for the following clock cycle.
- This parameter specifies the maximum allowable skew between DSACK0 to DSACK1 asserted or DSACK1 to DSACK0 asserted; specification #47A must be met by DSACK0 or DSACK1.
- This specification applies to the first (DSACKO or DSACKI) DSACKx signal asserted. In the absence of DSACKx, BERR is an asynchronous input using the asynchronous input setup time (#47A).
- 5. DBEN may stay asserted on consecutive write cycles.
- The minimum values must be met to guarantee proper operation. If this maximum value is exceeded, BG may be reasserted.
- 7. This specification indicates the minimum high time for ECS and OCS in the event of an internal cache hit followed immediately by another cache hit, a cache miss, or an operand cycle.
- 8. This specification guarantees operation with the MC68881/MC68882, which specifies a minimum time for DS negated to AS asserted (specification #13A in the MC68881/MC68882 User's Manual). Without this specification, incorrect interpretation of specifications #9A and #15 would indicate that the MC68030 does not meet the MC68881/MC68882 requirements.
- This specification allows a system designer to guarantee data hold times on the output side of data buffers that have output enable signals generated with DBEN. The timing on DBEN precludes its use for synchronous READ cycles with no wait states.
- 10. These specifications allow system designers to guarantee that an alternate bus master has stopped driving the bus when the MC68030 regains control of the bus after an arbitration sequence.
- .11. DS will not be asserted for synchronous write cycles with no wait states.
- 12. These hold times are specified with respect to strobes (asynchronous) and with respect to the clock (synchronous). The designer is free to use either time.
- 13. Synchronous inputs must meet specifications #60 and #61 with stable logic levels for all rising edges of the clock while AS is asserted. These values are specified relative to the high level of the rising clock edge. The values originally published were specified relative to the low level of the rising clock edge.
- 14. This specification allows system designers to qualify the \overline{CS} signal of an MC68881/MC68882 with \overline{AS} (allowing 7 ns for a gate delay) and still meet the \overline{CS} to \overline{DS} setup time requirement (spec 8B) of the MC68881/MC68882.



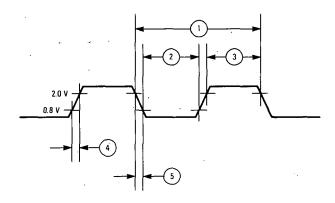


Figure 2. Clock Input Timing Diagram



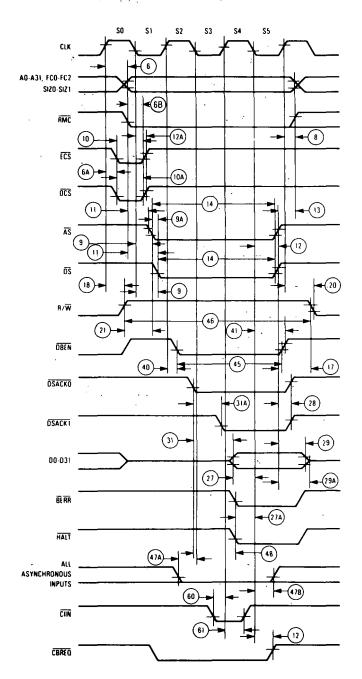


Figure 3. Asynchronous Read Cycle Timing Diagram



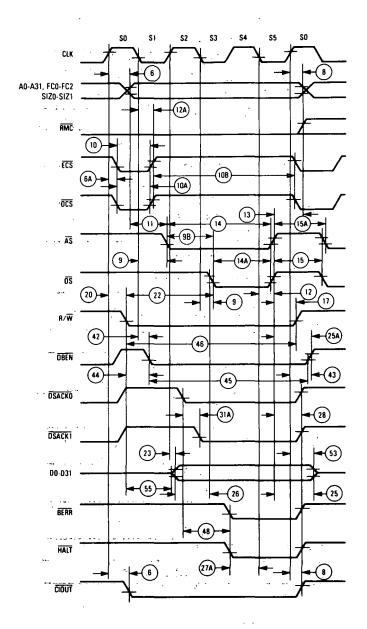


Figure 4. Asynchronous Write Cycle Timing Diagram



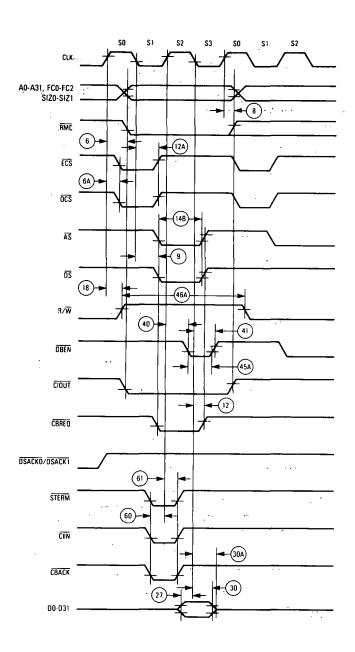


Figure 5. Synchronous Read Cycle Timing Diagram



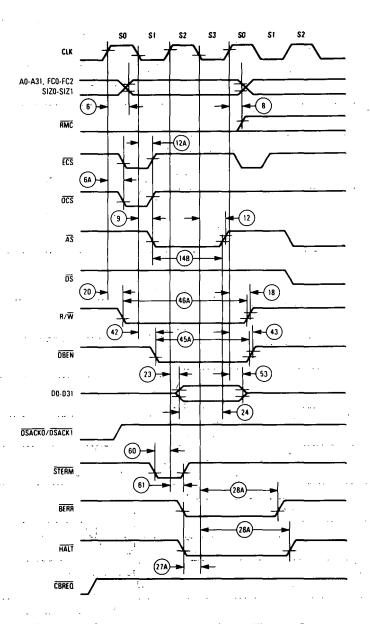


Figure 6. Synchronous Write Cycle Timing Diagram



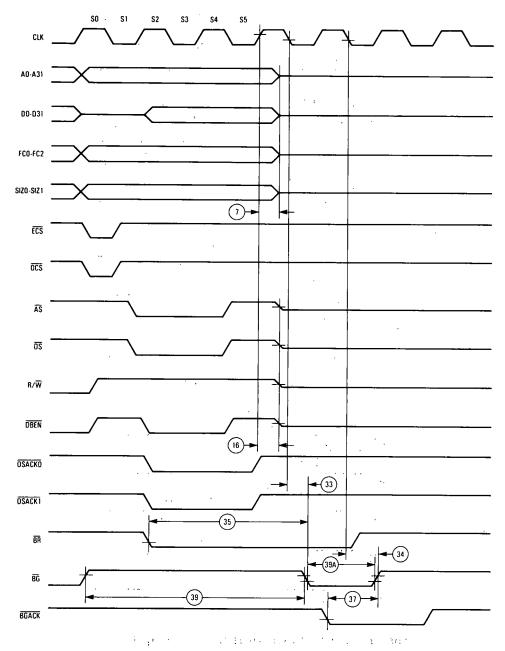


Figure 7. Bus Arbitration Timing Diagram



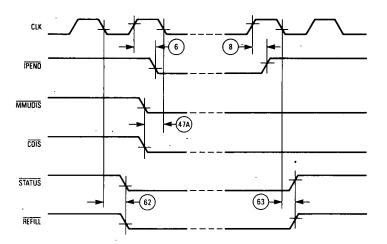


Figure 8. Other Signal Timings

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